

IFN424, IFN425, IFN426

Dual N-Channel Silicon Junction Field-Effect Transistor

- Very High Impedance Differential Amplifiers
- Electrometers

Absolute maximum ratings at $T_A = 25^\circ\text{C}$

Device Dissipation (Derate 3.2 mW/ $^\circ\text{C}$ to 50 $^\circ\text{C}$)	400 mW
Total Device Dissipation (Derate 6 mW/ $^\circ\text{C}$ to 150 $^\circ\text{C}$)	750 mW
Storage Temperature Range	-60 $^\circ\text{C}$ to 200 $^\circ\text{C}$

At 25 $^\circ\text{C}$ free air temperature:**Static Electrical Characteristics**

		IFN424, IFN425, IFN426			Process NJ01	
		Min	Typ	Max	Unit	Test Conditions
Gate Source Breakdown Voltage	$V_{(\text{BR})\text{GSS}}$	-40	-60		V	$I_G = -1 \mu\text{A}, V_{DS} = \emptyset \text{V}$
Gate to Gate Breakdown Voltage	BV_{G1G2}	± 40			V	$I_G = -1 \mu\text{A}, I_D = \emptyset \text{A}, I_S = \emptyset \text{A}$
Gate Reverse Current	I_{GSS}			-3	pA	$V_{GS} = -20 \text{V}, V_{DS} = \emptyset \text{V}$
				-3	nA	$V_{GS} = -20 \text{V}, V_{DS} = \emptyset \text{V}$
Gate Operating Current	I_G			-0.5	pA	$V_{DS} = 10 \text{V}, I_D = 30 \mu\text{A}$
				-500	pA	$V_{DS} = 10 \text{V}, I_D = 30 \mu\text{A}$
Gate Source Cutoff Voltage	$V_{GS(\text{OFF})}$	-0.4		-3	V	$V_{DS} = 10 \text{V}, I_D = 1 \text{nA}$
Gate Source Voltage	V_{GS}			-2.9	V	$V_{DS} = 10 \text{V}, I_D = 30 \mu\text{A}$
Drain Saturation Current (Pulsed)	I_{DSS}	60	1800		μA	$V_{DS} = 10 \text{V}, V_{GS} = \emptyset \text{V}$

Dynamic Electrical Characteristics

Common Source Forward Transconductance	g_{fs}	100		1500	μS	$V_{DS} = 10 \text{V}, V_{GS} = \emptyset \text{V}$	$f = 1 \text{ kHz}$
Common Source Output Conductance	g_{os}			3	μS	$V_{DS} = 10 \text{V}, I_D = 30 \mu\text{A}$	$f = 1 \text{ kHz}$
Common Source Input Capacitance	C_{iss}			3	pF	$V_{DS} = 10 \text{V}, V_{GS} = \emptyset \text{V}$	$f = 1 \text{ MHz}$
Common Source Reverse Transfer Capacitance	C_{rss}			1.5	pF	$V_{DS} = 10 \text{V}, V_{GS} = \emptyset \text{V}$	$f = 1 \text{ MHz}$
Equivalent Short Circuit Input Noise Voltage	\bar{e}_N		20	70	$\text{nV}/\sqrt{\text{Hz}}$	$V_{DS} = 10 \text{V}, I_D = 30 \mu\text{A}$	$f = 10 \text{ Hz}$
Noise Figure	NF			1	dB	$V_{DS} = 10 \text{V}, I_D = 30 \mu\text{A}$ $R_G = 1 \text{ M}\Omega$	$f = 10 \text{ Hz}$

Max - IFN424 IFN425 IFN426

Differential Gate Source Voltage	$ V_{GS1}-V_{GS2} $	10	15	25	mV	$V_{DG} = 10 \text{V}, I_D = 30 \mu\text{A}$	
Differential Gate Source Voltage With Temperature	$\frac{ V_{GS1}-V_{GS2} }{\Delta T}$	10	25	40	$\mu\text{V}/\text{ }^\circ\text{C}$	$V_{DG} = 10 \text{V}, I_D = 30 \mu\text{A}$	$T_A = -55^\circ\text{C}$ $T_B = 25^\circ\text{C}$ $T_C = 125^\circ\text{C}$

Min - IFN424 IFN425 IFN426

Common Mode Rejection Ratio	CMRR	90	80	80	dB	$V_{DG} = 10 \text{V} \text{ to } 20 \text{V}, I_D = 30 \mu\text{A}$	
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TO-78 Package

See Section G for Outline Dimensions

Pin Configuration1 Source 1, 2 Drain 1, 3 Gate 1, 4 Case,
5 Source 2, 6 Drain 2, 7 Gate 2,
8 Omitted